

<b>Notice of References Cited</b>	Application/Control No. 10/053,585	Applicant(s)/Patent Under Reexamination NAYA ET AL.	
	Examiner Christopher L. Chin	Art Unit 1641	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,611,367	08-2003	Naya et al.	359/299
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	K	US-			
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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